Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
‖‖‖‖‖‖‖ (barcode)	10/688,264	CERN, YEHUDA
	Examiner	**Art Unit**
	Dean O. Takaoka	2817

ISSUE CLASSIFICATION

ORIGINAL			CROSS REFERENCE(S)						
CLASS	**SUBCLASS**	**CLASS**	**SUBCLASS (ONE SUBCLASS PER BLOCK)**						
333	175	336	175						
INTERNATIONAL CLASSIFICATION		340	310.17						
H 0 1 F	17/04	307	147						
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(Assistant Examiner) (Date)	(signature) Dean Takaoka 10/3/2005 (Primary Examiner) (Date)	**Total Claims Allowed: 4**	
(signature) Javen Hayes 10/5/05 (Legal Instruments Examiner) (Date)		**O.G. Print Claim(s)** 1	**O.G. Print Fig.** 1

☐ **Claims renumbered in the same order as presented by applicant** ☐ CPA ☐ T.D. ☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		61		91		121		151		181
2	2		32		62		92		122		152		182
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	7		37		67		97		127		157		187
	8		38		68		98		128		158		188
	9		39		69		99		129		159		189
	10		40		70		100		130		160		190
	11		41		71		101		131		161		191
	12		42		72		102		132		162		192
	13		43		73		103		133		163		193
	14		44		74		104		134		164		194
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	17		47		77		107		137		167		197
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	19		49		79		109		139		169		199
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	23		53		83		113		143		173		203
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	27		57		87		117		147		177		207
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	29		59		89		119		149		179		209
	30		60		90		120		150		180		210